

Studies and possible mitigation of electron cloud effects in FCC-ee

Fatih Yaman, Izmir Institute of Technology

Frank Zimmermann, CERN

Many Thanks: the FCC-ee optics team

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- **FCC-ee parameters** : machine, beam
- **Overview** : SEY Models, PyECLLOUD
- **Electron densities at pipe center** : reference, min. and max.
- **Average of min.'s vs estimated threshold** : Drift, Dipole regions
- **Mitigation Ideas**
- **Conclusions**

FCC-ee Collider Arc Dipole Parameters

Parameters	2 IPs	4 IPs
beam energy [GeV]	45.6	45.6
bunches per train	150	150
trains per beam	1	1
circular beam pipe radius [mm]	35	35
r.m.s. bunch length (σ_z) [mm]	3.5	4.32
h. r.m.s. beam size (σ_x) [μm]	120	207
v. r.m.s. beam size (σ_y) [μm]	7	12.1
number of particles / bunch (10^{11})	1.7	2.76
bend field [T]	0.01415	0.01415
circumference C [m]	97.76	91.2
synchrotron tune Q_s	0.025	0.037
average beta function β_y [m]	50	50
threshold density (10^{12} [m^{-3}])	0.027	0.043

threshold density
(single-bunch instability)

$$\rho_{\text{thr}} = \frac{2\gamma Q_s \omega_e \sigma_z / c}{\sqrt{3} K Q r_e \beta_y C}$$

$$\omega_e = \left(\frac{N_b r_e c^2}{\sqrt{2\pi} \sigma_z \sigma_y (\sigma_x + \sigma_y)} \right)^{1/2}$$

$$K = \omega_e \sigma_z / c$$

$$Q = \min(\omega_e \sigma_z / c, 7)$$



K. Ohmi, Beam-beam and electron cloud effects in CEPC / FCC-ee, Int. Journal of Modern Physics A, 31(33), 1644014 (2016).



K. Ohmi, F. Zimmermann and E. Perevedentsev, Wake-field and fast head-tail instability caused by an electron cloud, Phys. Rev. E 65, 016502 (2001).



F.Yaman, G.Iadarola, R. Kersevan, S. Ogur, K. Ohmi, F. Zimmermann and M. Zobov, Mitigation of Electron Cloud Effects in the FCC-ee Collider, arXiv:2203.04872, (2022).

PE generation rate
 $\{1e-3, 1e-4, 1e-5, 1e-6\} \text{ m}^{-1}$

$$n'_\gamma = Y_\gamma \frac{5 \alpha \gamma}{2 \sqrt{3} \rho}$$

≈ 0.1

number of photoelectrons emitted per length

fine structure constant

$$\alpha \approx 1/137$$

the Lorentz factor

$$\gamma \approx 10^5$$

radius of curvature of the particle path

$$\rho \approx 11000 \text{ [m]}$$

Furman-Pivi & ECLOUD SEY Models

M.A. Furman and M.T.F. Pivi, 'Probabilistic Model for the Simulation of Secondary Electron Emission', SLAC-PUB-9912, 2003

TABLE I: Main parameters of the model.

	Copper	Stainless Steel
Emitted angular spectrum (Sec. II C 1)		
α	1	1
Backscattered electrons (Sec. III B)		
$P_{1,e}(\infty)$	0.02	
$\hat{P}_{1,e}$	0.496	
\hat{E}_e [eV]	0	
W [eV]	60.86	
p	1	0.9
σ_e [eV]	2	1.9
e_1	0.26	0.26
e_2	2	2
Rediffused electrons (Sec. III C)		
$P_{1,r}(\infty)$	0.2	0.74
E_r [eV]	0.041	40
r	0.104	1
q	0.5	0.4
r_1	0.26	0.20
r_2	2	2
True secondary electrons (Sec. III D)		
$\hat{\delta}_{ts}$	1.8848	1.22
\hat{E}_{ts} [eV]	276.8	310
s	1.54	1.813
t_1	0.66	0.66
t_2	0.8	0.8
t_3	0.7	0.7
t_4	1	1
Total SEY^a		
\hat{E}_t [eV]	271	292
$\hat{\delta}_t$	2.1	2.05

^aNote that $\hat{E}_t \simeq \hat{E}_{ts}$ and $\hat{\delta}_t \simeq \hat{\delta}_{ts} + P_{1,e}(\infty) + P_{1,r}(\infty)$ provided that $\hat{E}_{ts} \gg \hat{E}_e, E_r$.

$$\delta_e(E_0, \theta_0) = \delta_e(E_0, \theta_0 = 0)[1 + e_1(1 - \cos^{e_2} \theta_0)]$$

$$\delta_r(E_0, \theta_0) = \delta_r(E_0, \theta_0 = 0)[1 + r_1(1 - \cos^{r_2} \theta_0)]$$

$$\delta_{ts}(E_0, \theta_0) = \hat{\delta}(\theta_0)D(E_0/\hat{E}(\theta_0)),$$

$$\delta(E_0, \theta_0) = \delta_e(E_0, \theta_0) + \delta_r(E_0, \theta_0) + \delta_{ts}(E_0, \theta_0)$$

^aNote that $\hat{E}_t \simeq \hat{E}_{ts}$ and $\hat{\delta}_t \simeq \hat{\delta}_{ts} + P_{1,e}(\infty) + P_{1,r}(\infty)$ provided that $\hat{E}_{ts} \gg \hat{E}_e, E_r$.

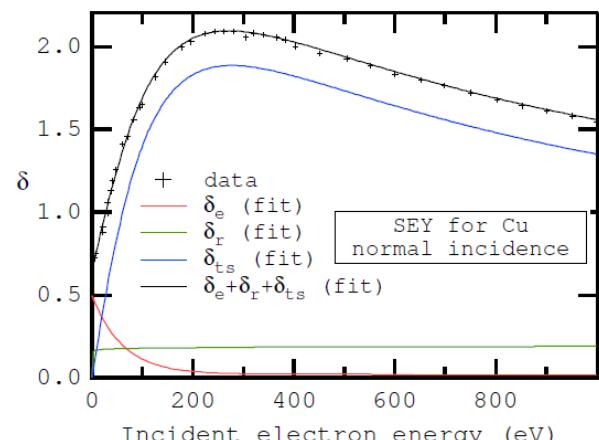
1.1

0.88

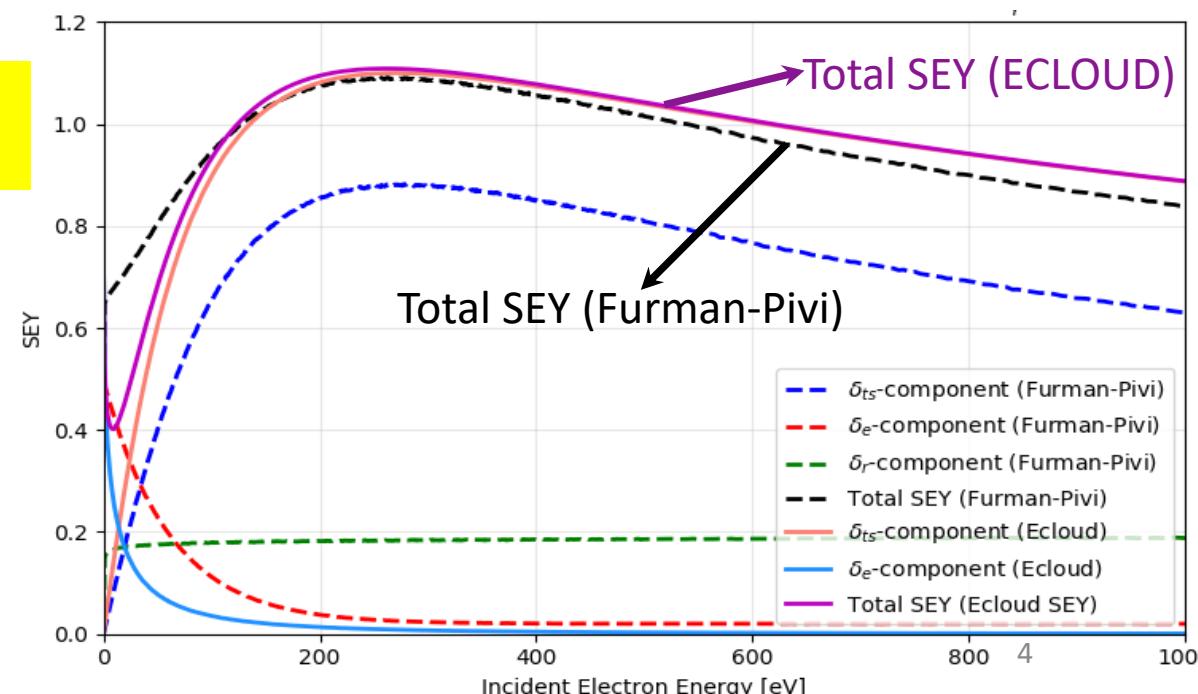
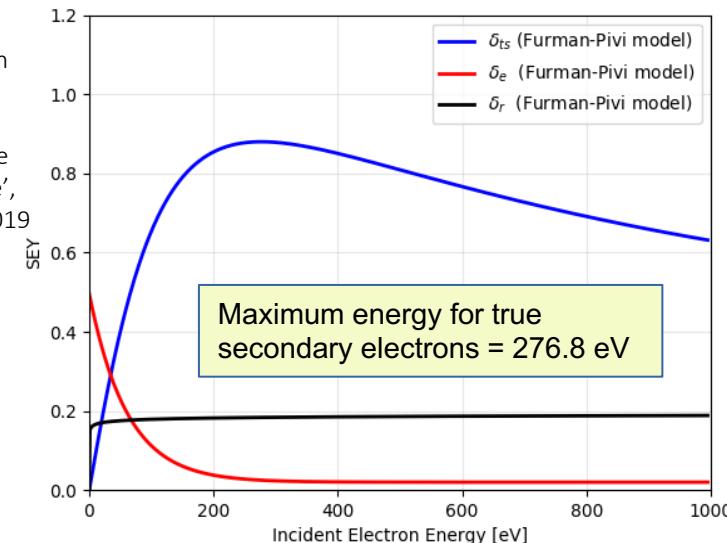
0.02

0.2

in this study
total SEY = {1.1, 1.2, 1.3, 1.4}



E.G. T. Wulff and G. Iadarola, 'Implementation and benchmarking of the Furman-Pivi model for Secondary Emission in the PyEcloud simulation code', CERN-ACC-2019-0029, 2019



Simulation Tool: PyECLOUD

PyECLOUD

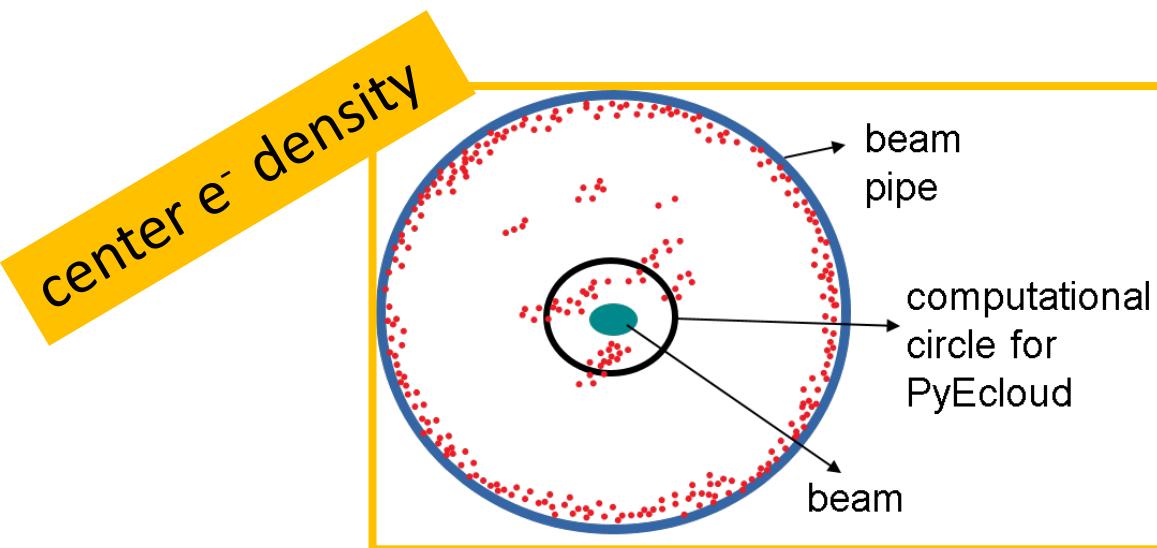
- 2D Electrostatic PIC simulation
- effects of space charge and secondary electrons are included
- adaptive scheme to control the number of electrons per macro particle during the simulation
- ECLOUD and Furman-Pivi SEY models



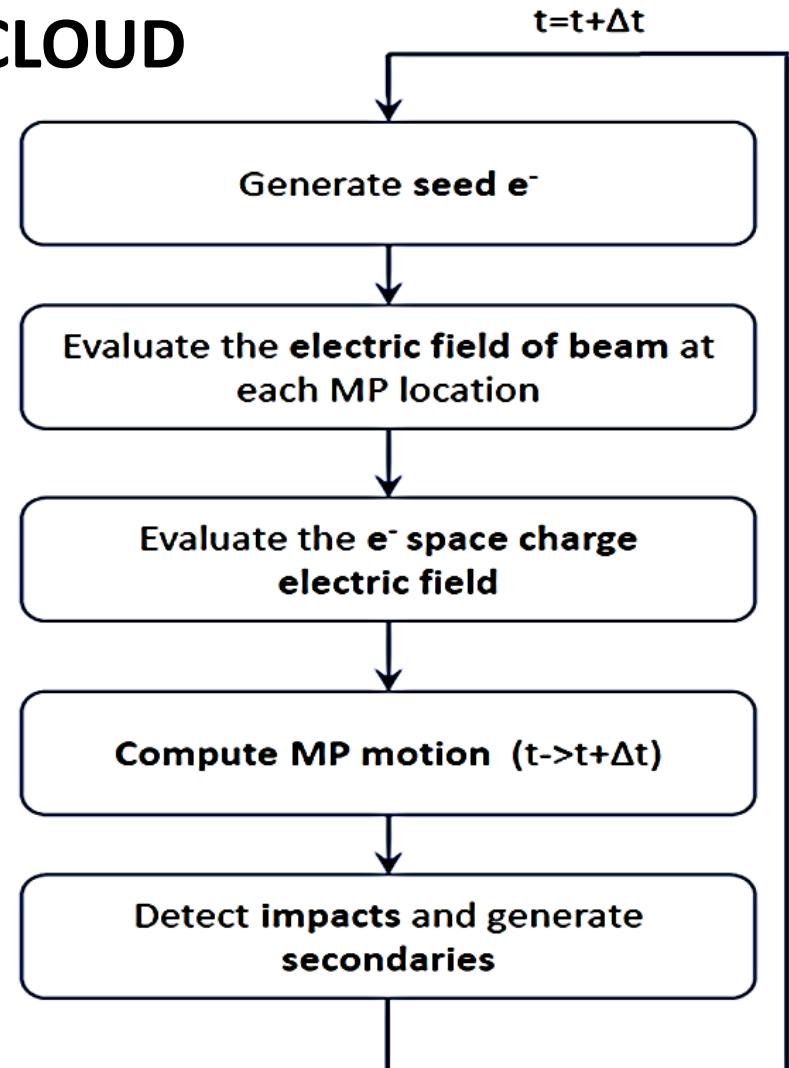
G. Iadarola, "Electron cloud studies for CERN particle accelerators and simulation code development" PhD Thesis, U. Naples, CERN-THESIS-2014-047, (2014).



N. Hiller et al., "Secondary electron emission data for the simulation of electron cloud", Proc. of ECLOUD'02, Geneva, Switzerland, CERN-2002-001, (2002).

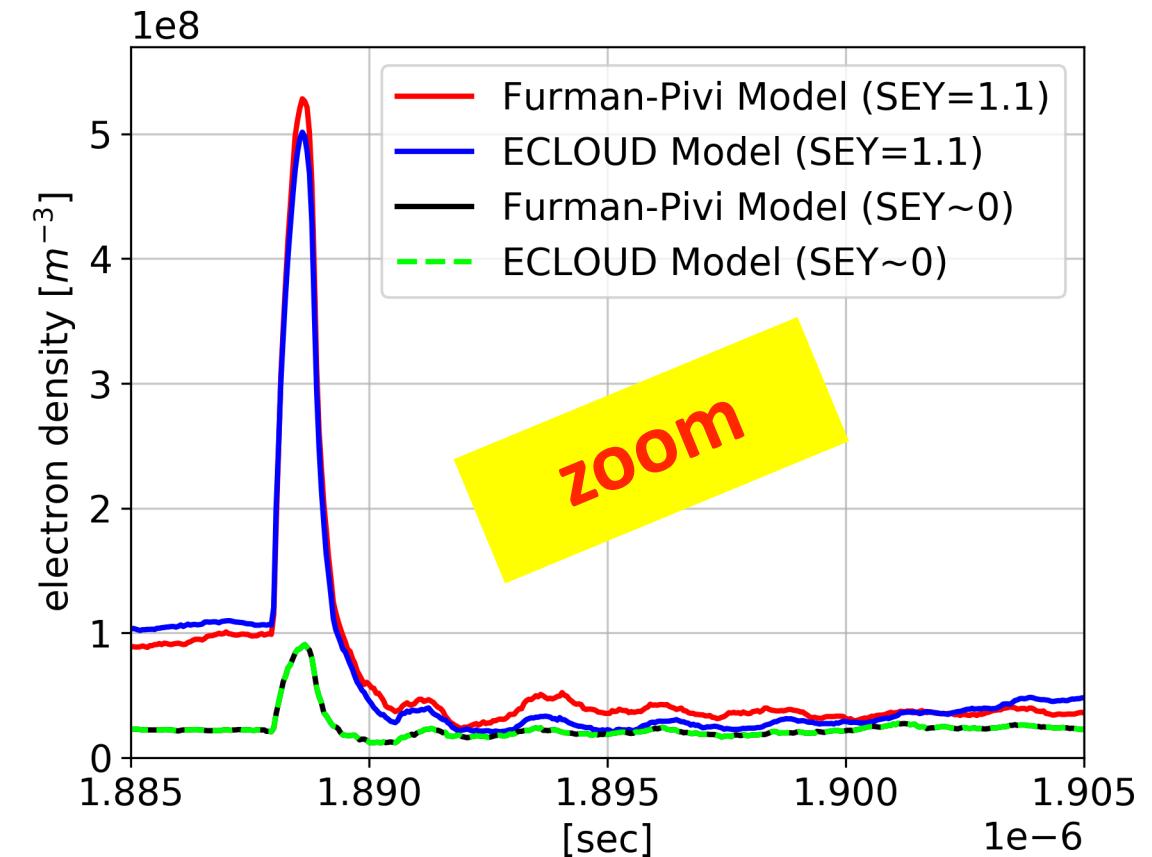
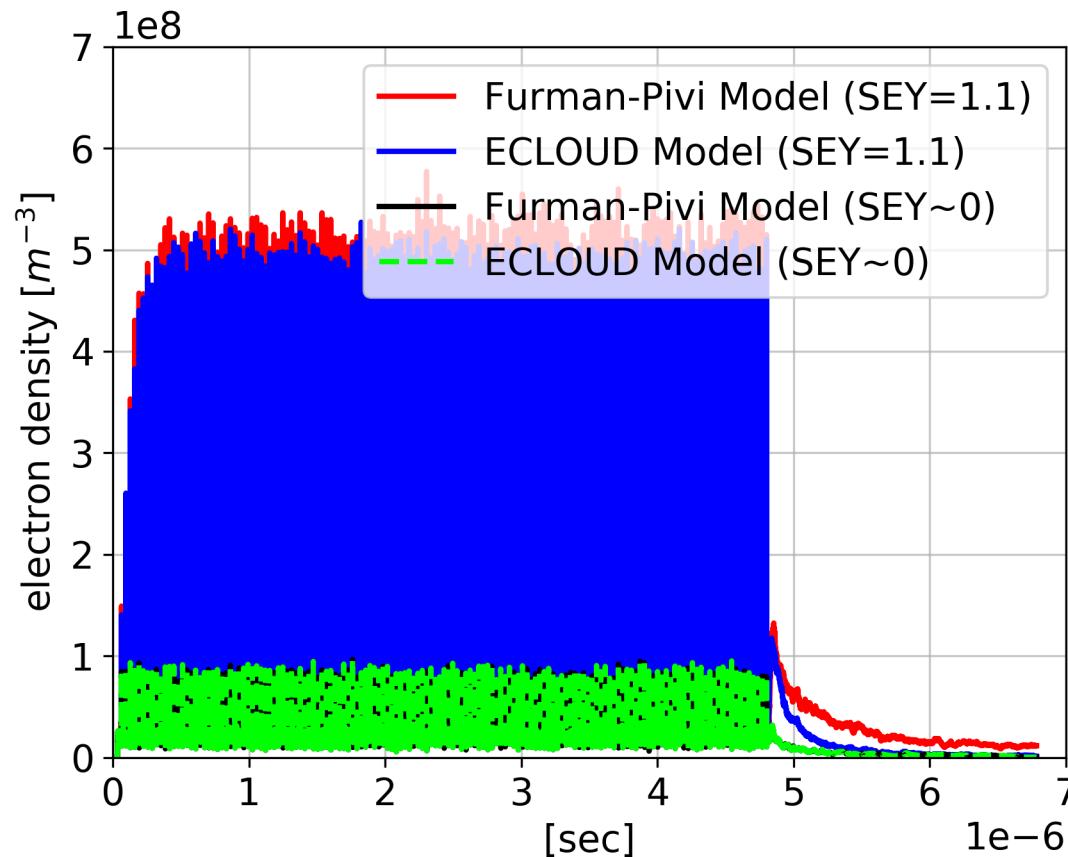


PyECLOUD



with the courtesy of G. Iadarola

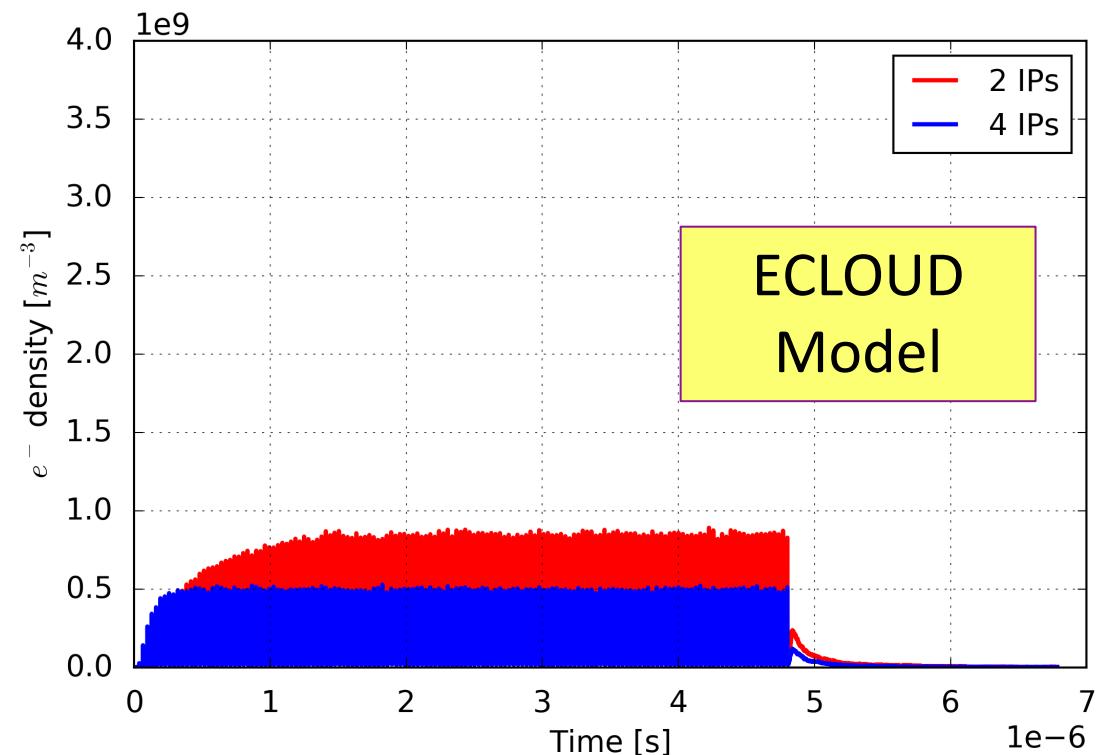
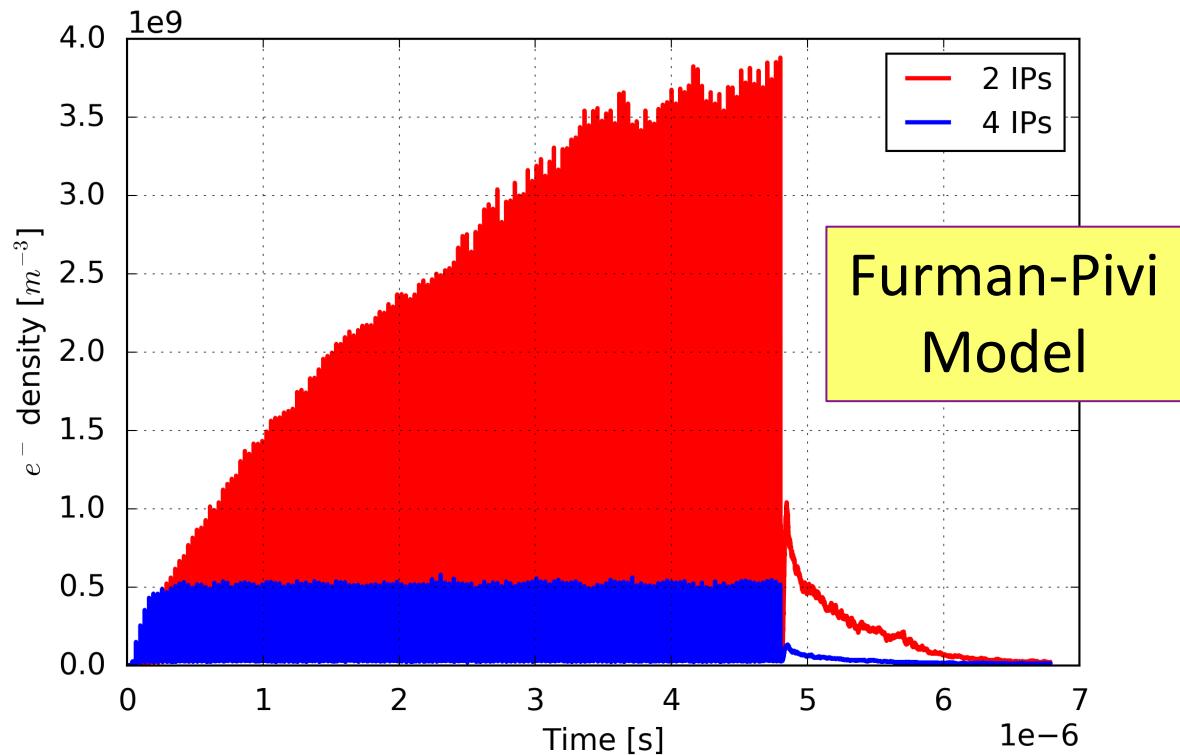
4 IPs ($n'_{(\gamma)} \rightarrow 1\text{e-6 m}^{-1}$, bunch spacing: 32ns) Dipole Region



- results via two SEY models agree well for $\text{SEY} \simeq 0$ (min. $\simeq 2\text{e}7 \text{ e}^-/\text{m}^3$)
- max. $\simeq 5\text{e}8 \text{ e}^-/\text{m}^3$ is verified with both models for $\text{SEY} = 1.1$

e^- densities for Arc Dipole at the pipe center

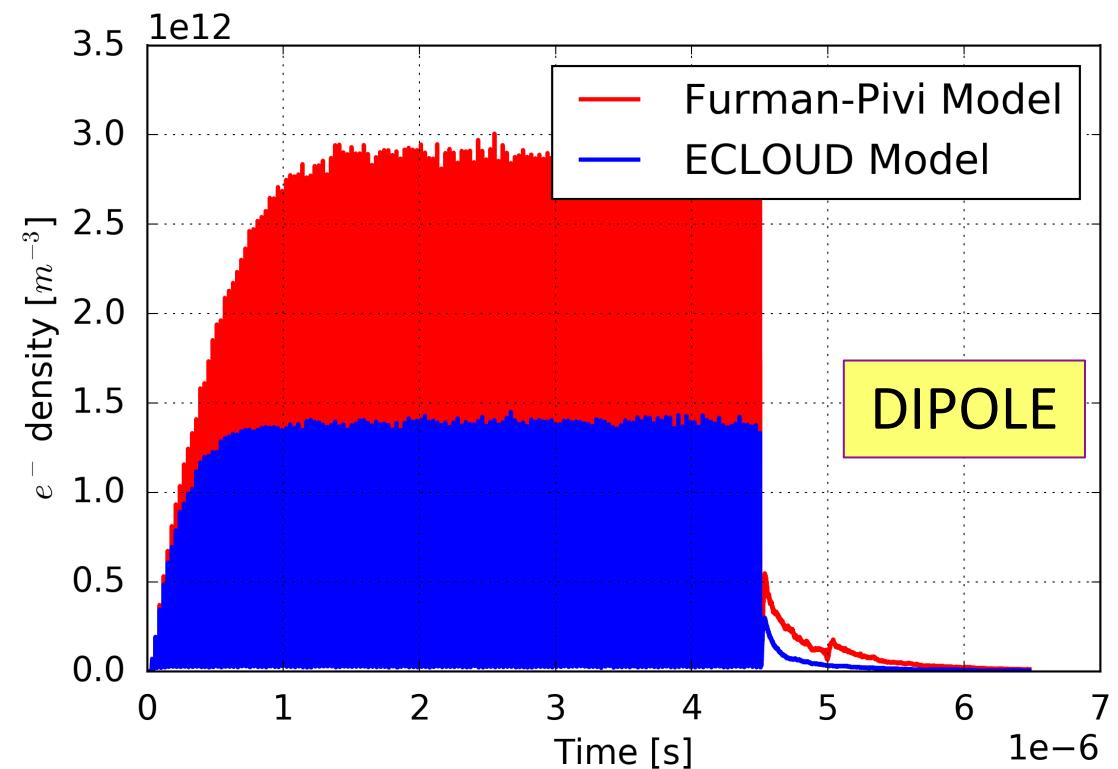
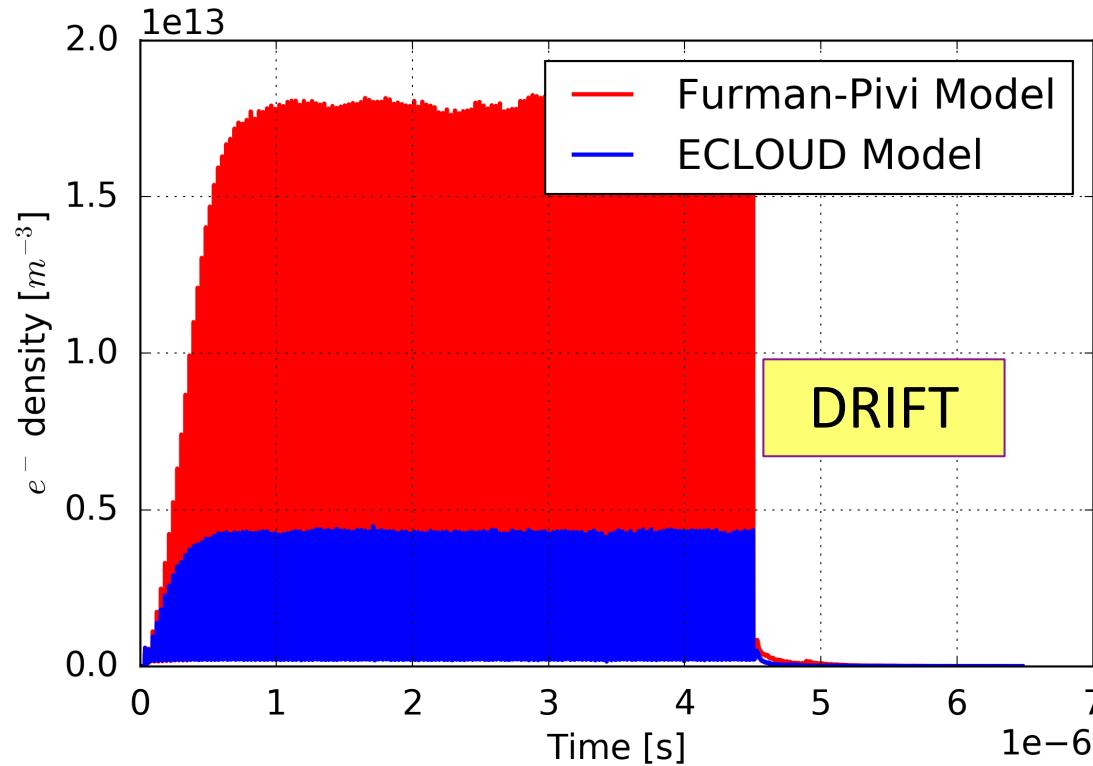
$SEY \simeq 1.1$, $n'_{(\gamma)} \rightarrow 1e-6 \text{ m}^{-1}$, bunch spacing: 32ns



- exponential-like growth for 2 IPs parameters via Furman-Pivi model
- results via two SEY models agree for 4 IPs parameters

4 IPs max. densities for Drift and Dipole regions

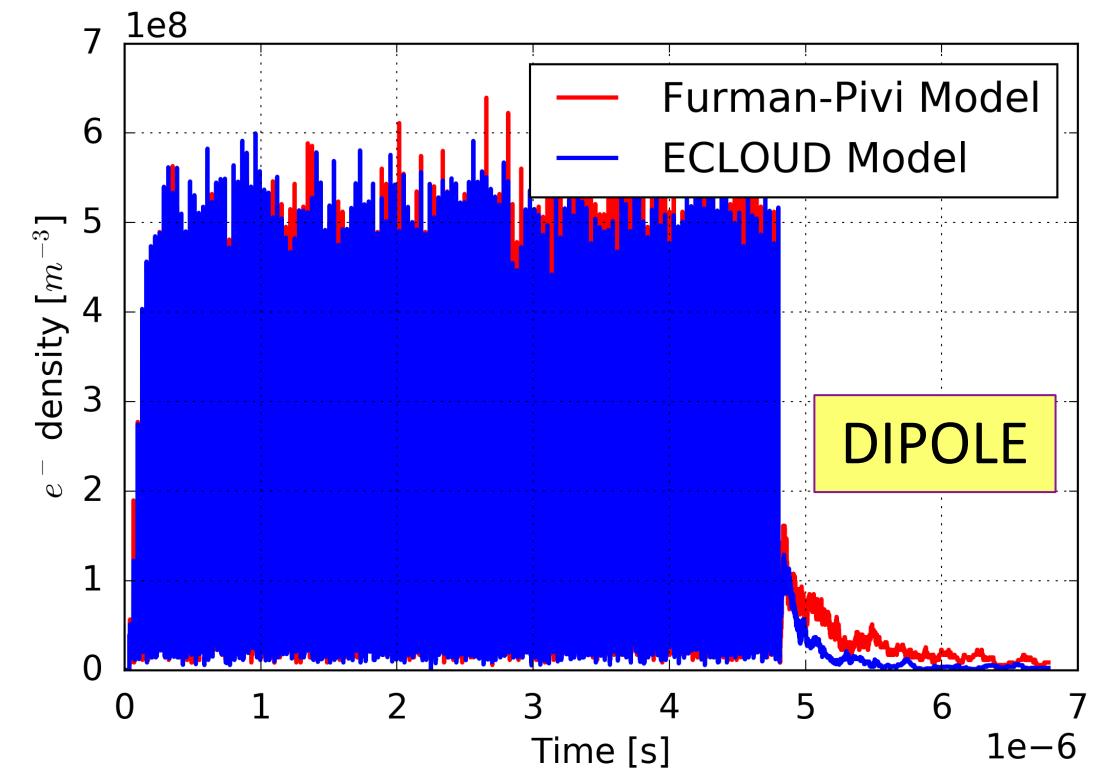
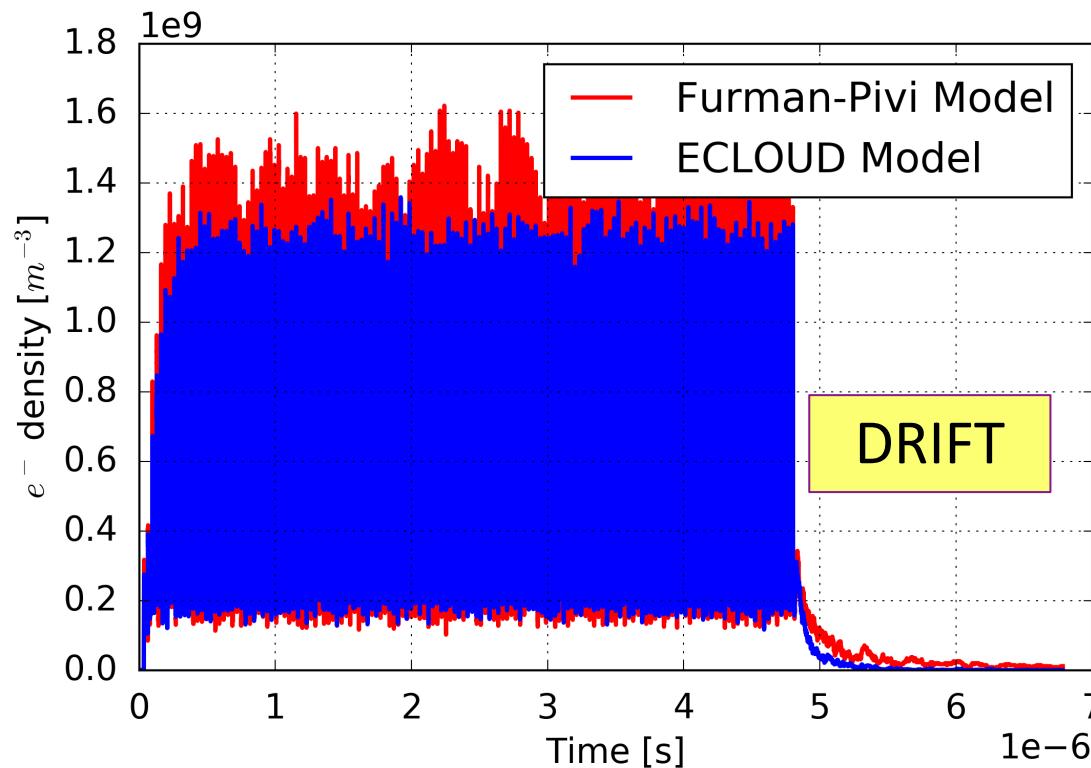
$SEY = 1.4$, $n'_{(\gamma)} = 1e-3 \text{ m}^{-1}$, bunch spacing: 30 ns



- computations via Furman-Pivi SEY model is more sensitive to external magnetic field
- ECLOUD SEY model may yield lower densities up to $\simeq 4$ times

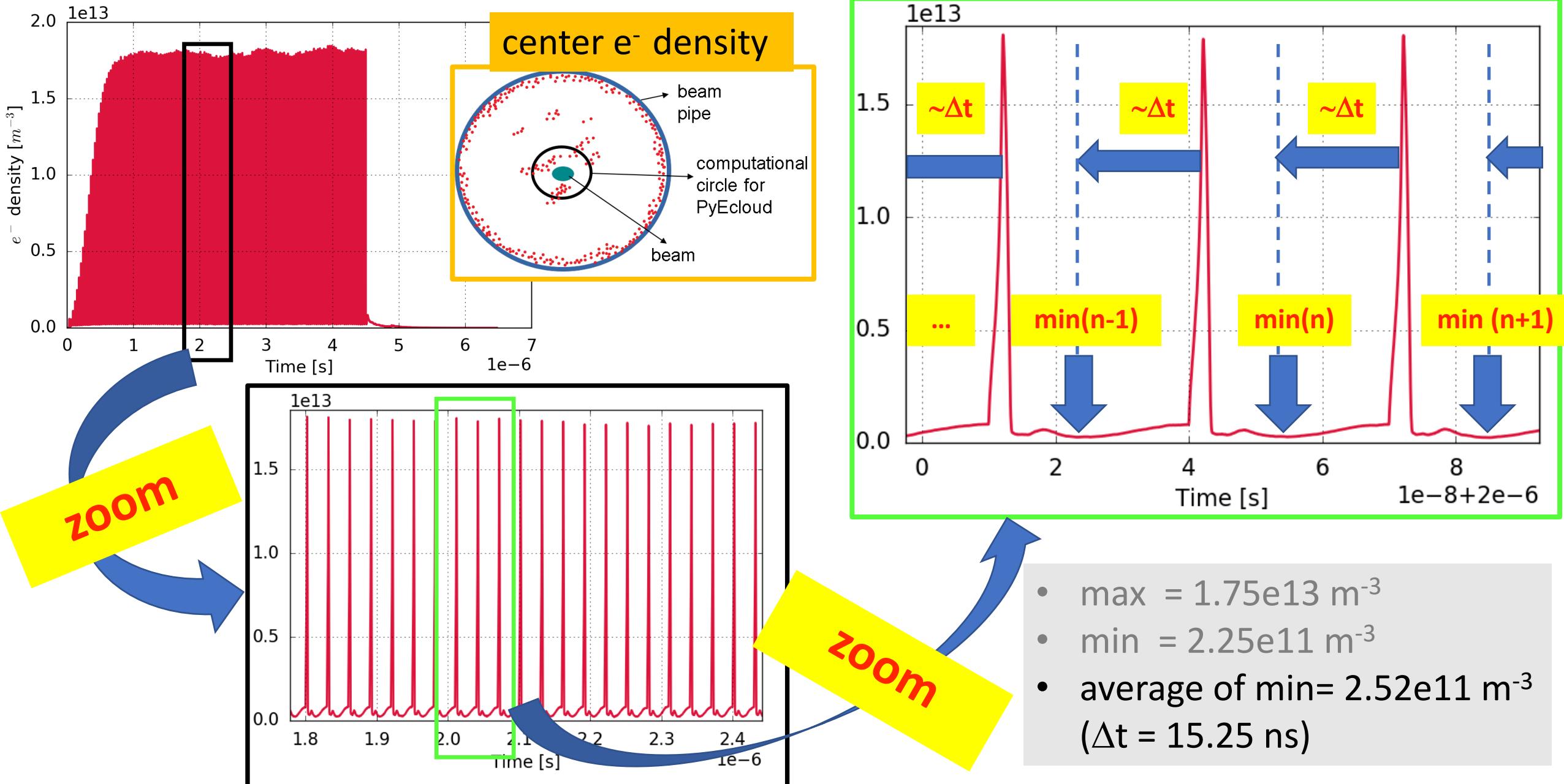
4 IPs min. densities for Drift and Dipole regions

$SEY = 1.1, n'_{(\gamma)} = 1e-6 \text{ m}^{-1}$, bunch spacing: 32 ns

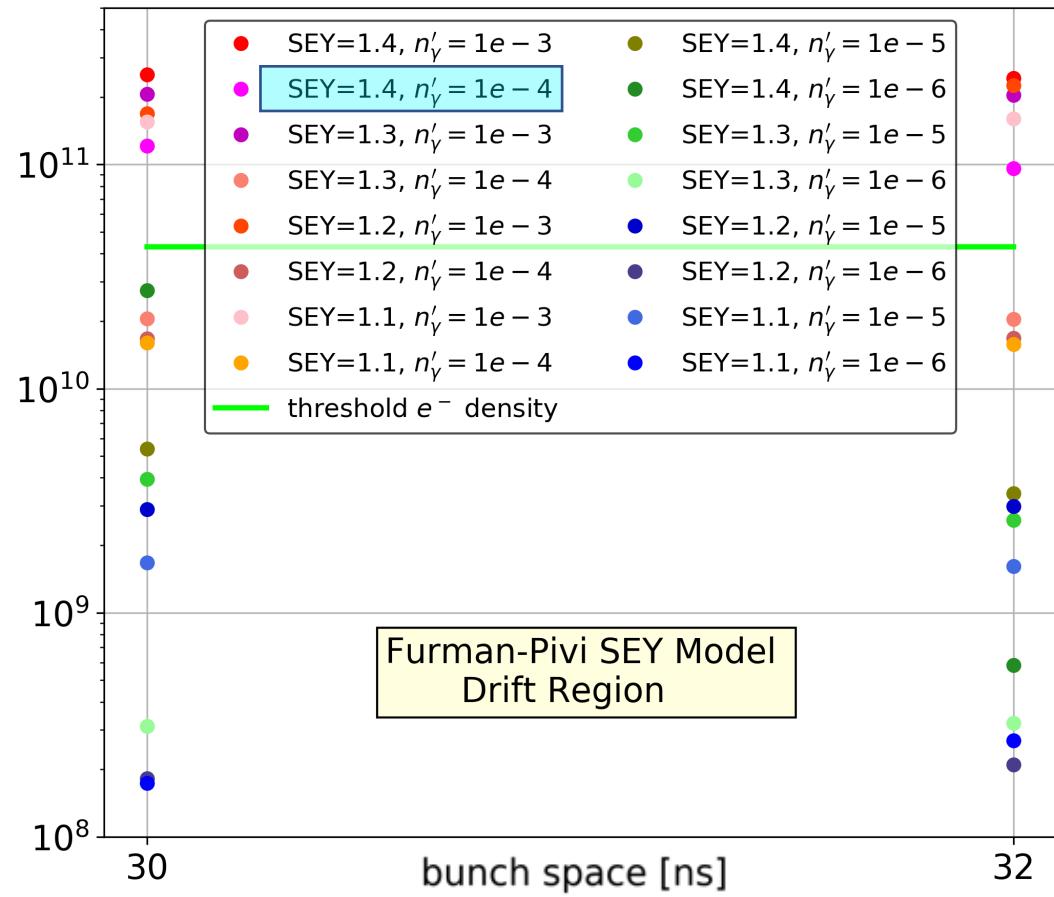
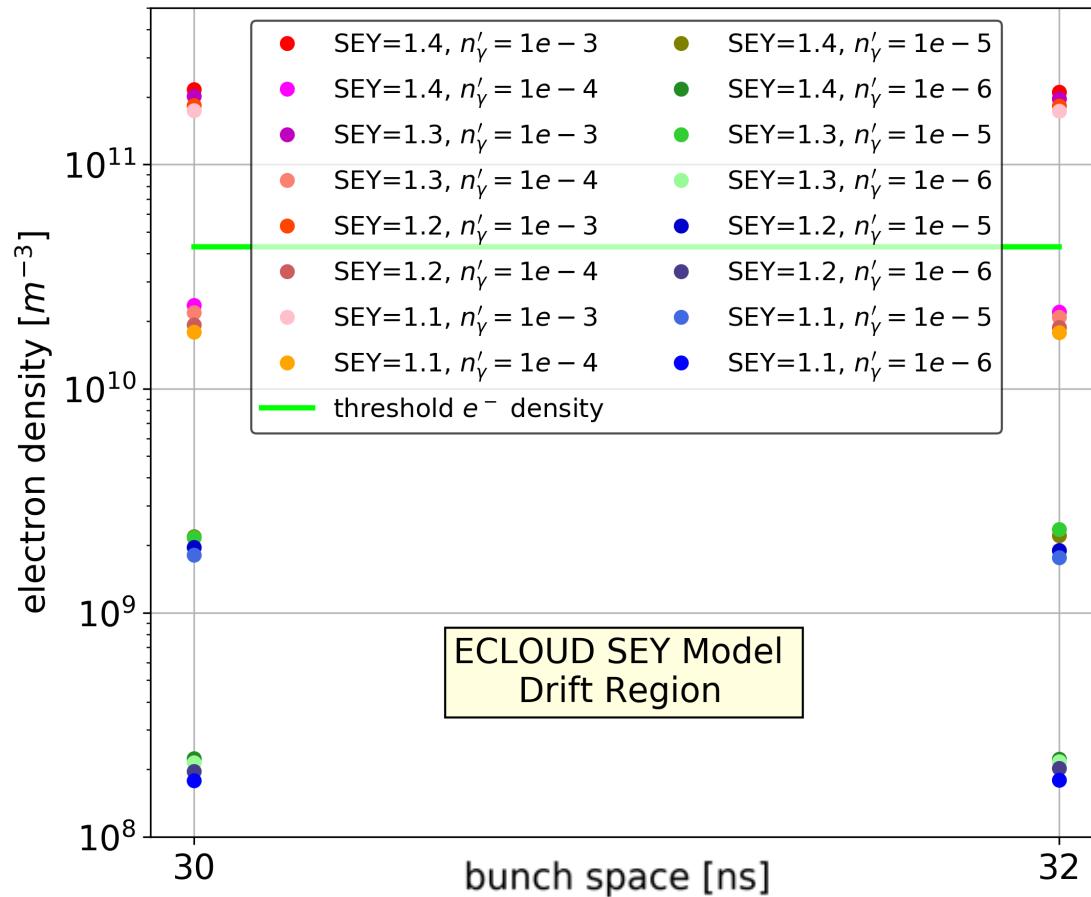


- both models yield similar results w.r.t. regions due to low SEY & PE (similar behaviours for 30ns bunch spacing)
- 0.01415 [T] external magnetic field $\simeq 2.5$ times lowers the densities for the weakest SEY & PE

Average of min.'s for center electron density



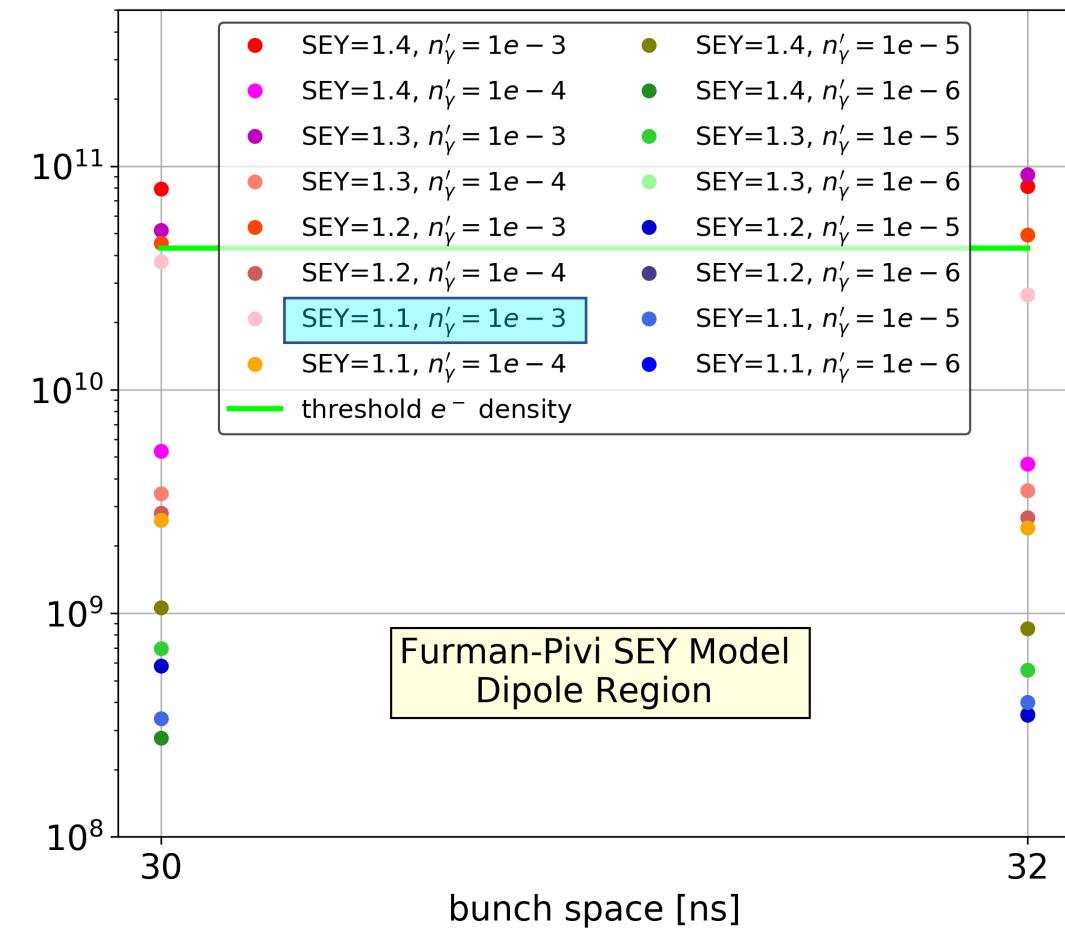
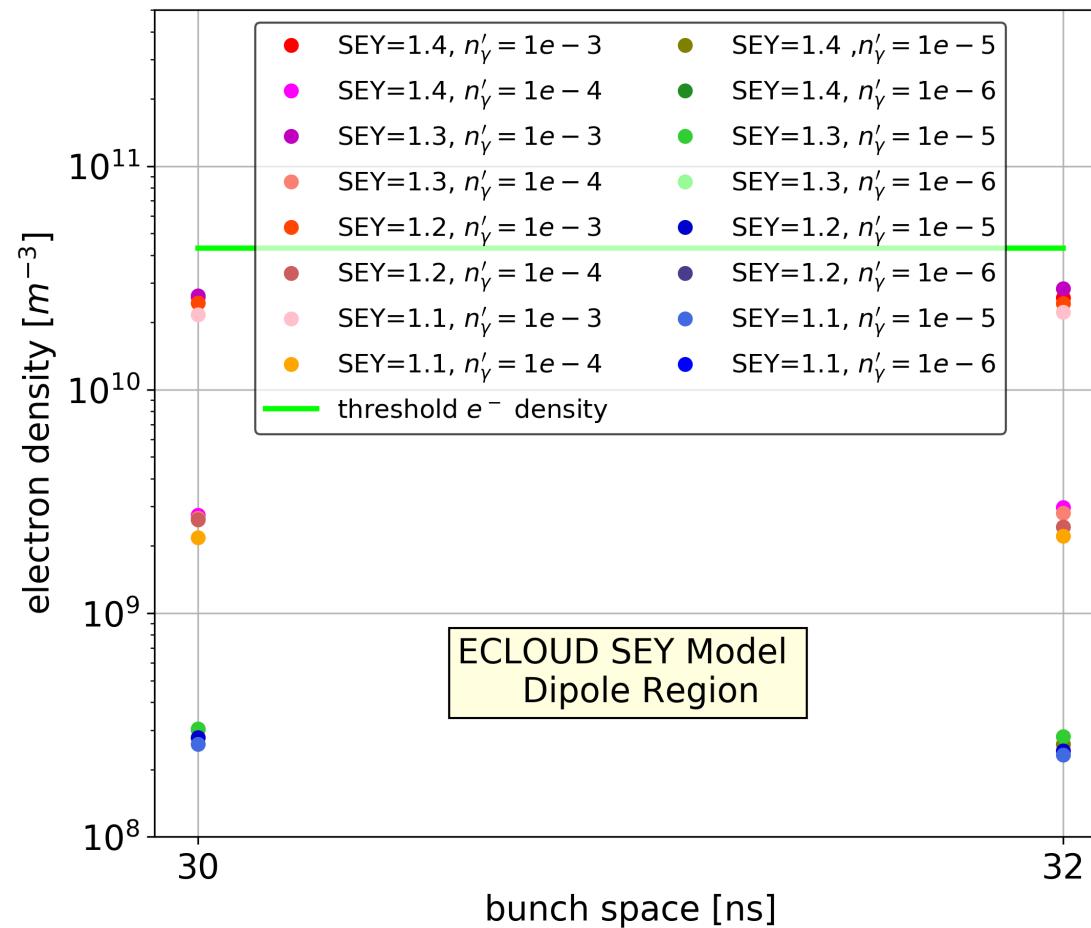
Threshold density and average min.'s for Drift



- $n'_{(\gamma)} < 1e-3 m^{-1}$ is necessary to keep average minimums lower than the threshold for both SEY models and bunch spacings
- $(n'_{(\gamma)} = 1e-4 m^{-1}, \text{SEY} = 1.4, \text{Furman-Pivi Model})$ indicates set of parameters for a value larger than threshold for both bunch spacings



Threshold density and average min.'s for Dipole



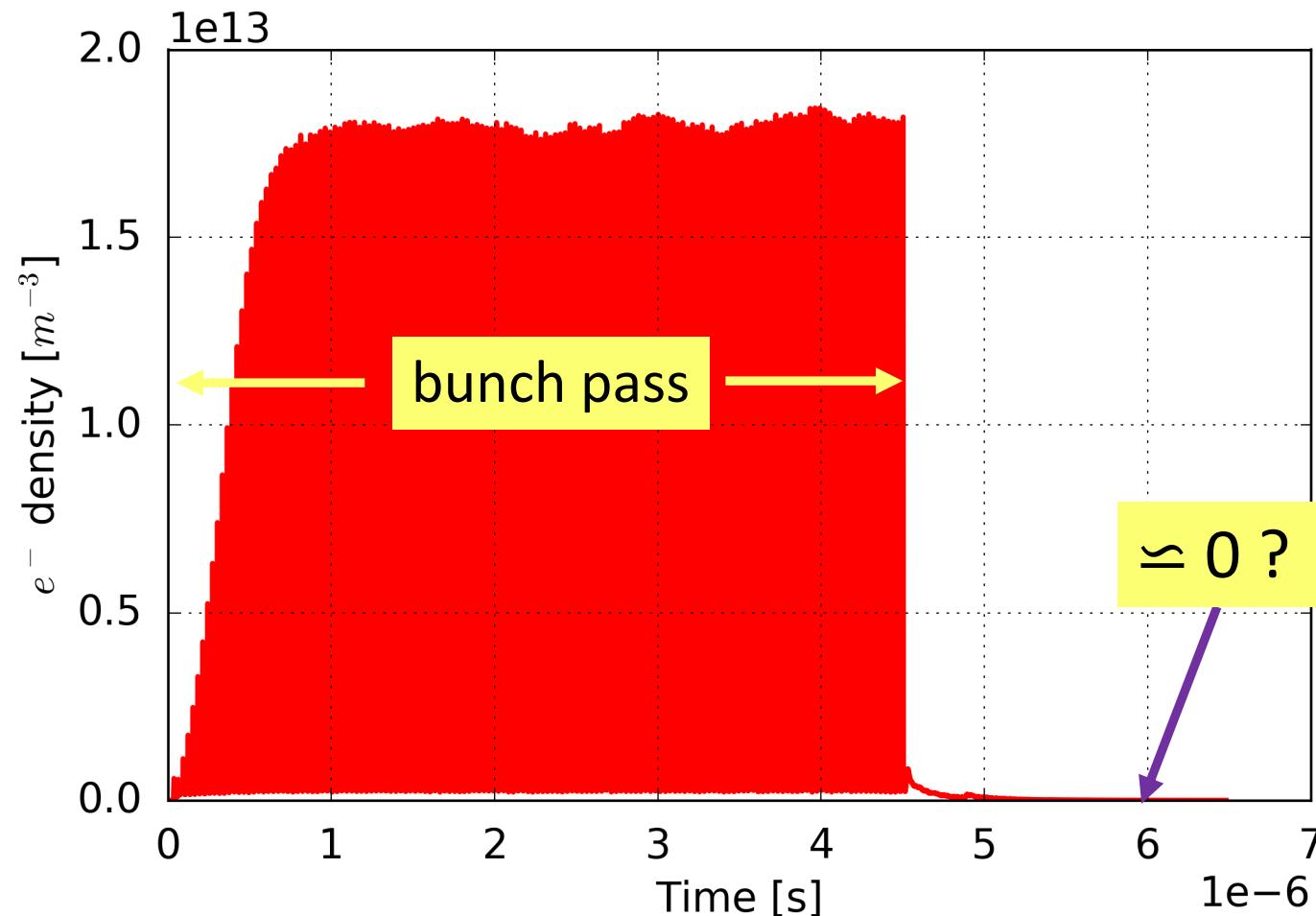
- all parametric scans using ECLOUD SEY model refer values lower than the estimated threshold
- $n'_{(\gamma)} < 1\text{e-}3 \text{ m}^{-1}$ is necessary to keep average minimums lower than the threshold for Furman-Pivi model (exceptional case: $n'_{(\gamma)} = 1\text{e-}3 \text{ m}^{-1}$, SEY=1.1)



Electron Cloud Mitigation

$$SEY = 1.4, n'_{(\gamma)} = 1e-3 \text{ m}^{-1},$$

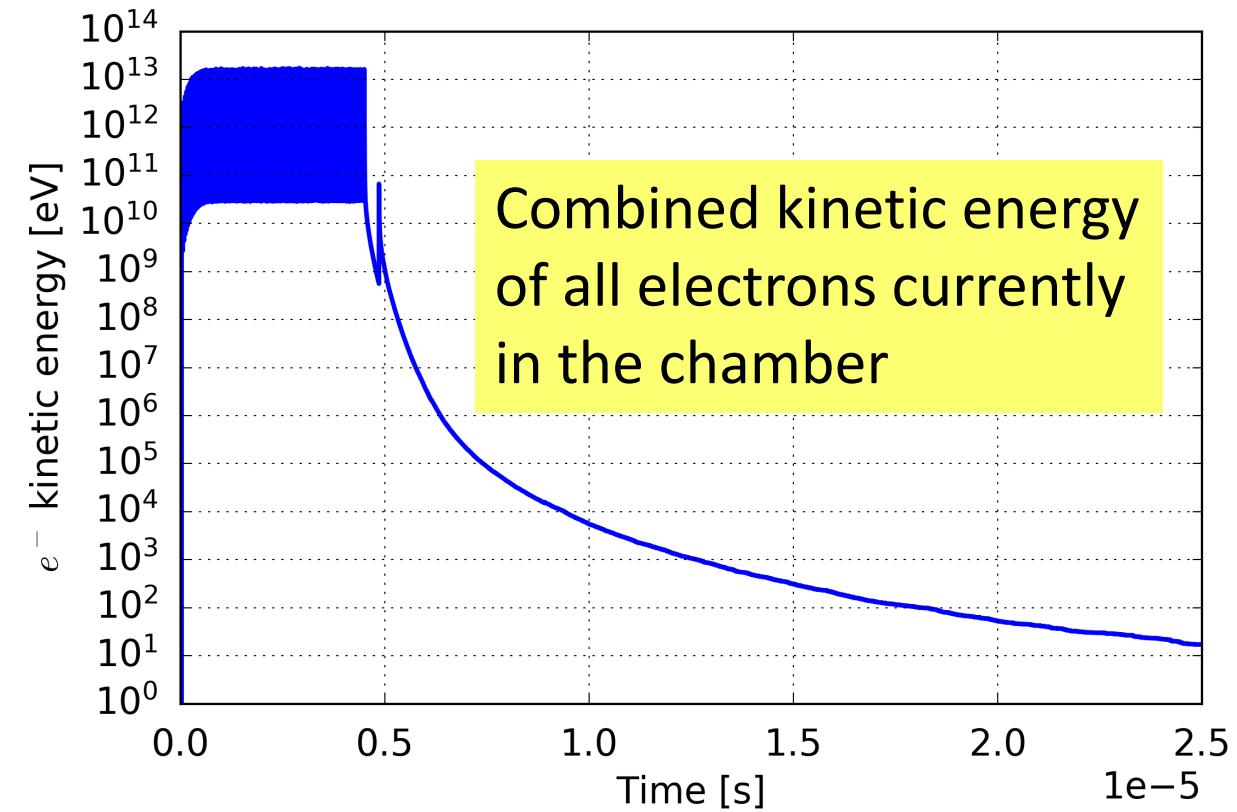
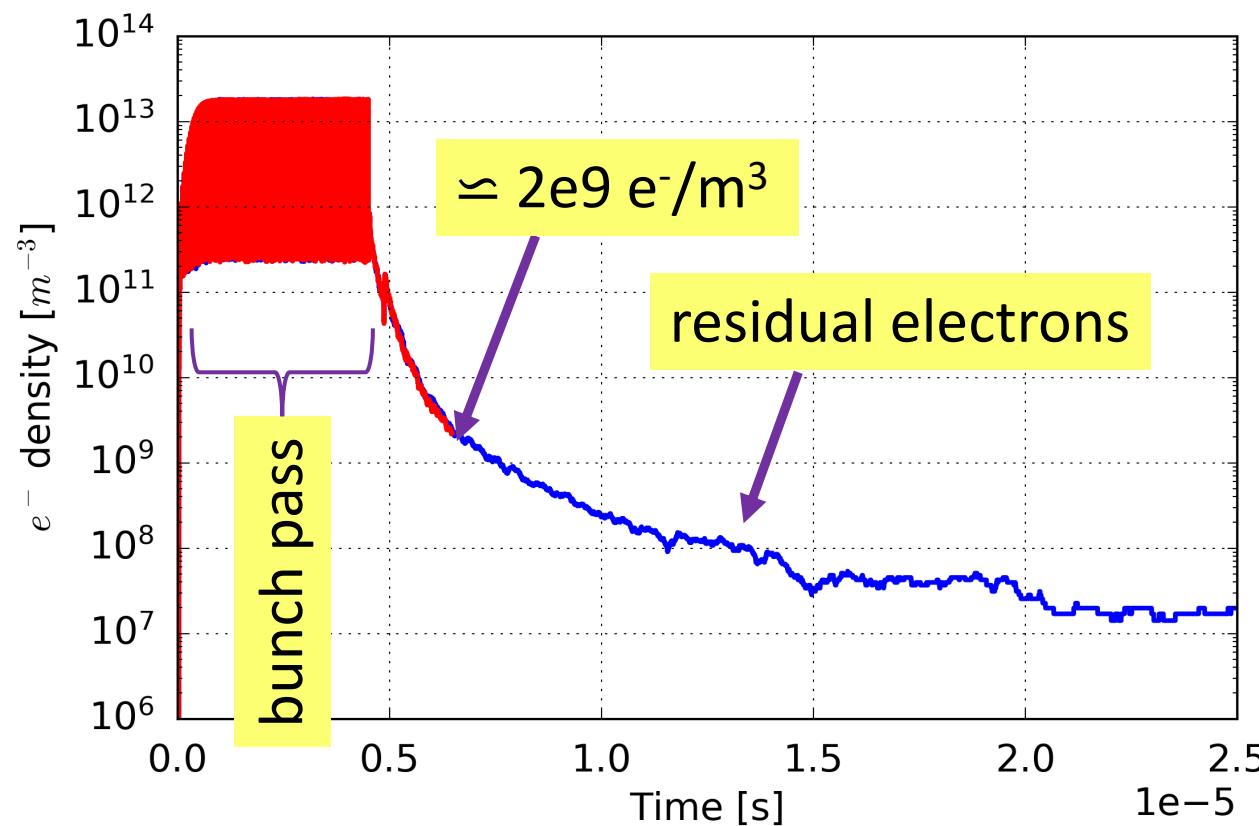
bunch spacing: 30 ns, Furman-Pivi Model, Drift Region



Electron Cloud Mitigation

$$SEY = 1.4, n'_{(\gamma)} = 1e-3 \text{ m}^{-1},$$

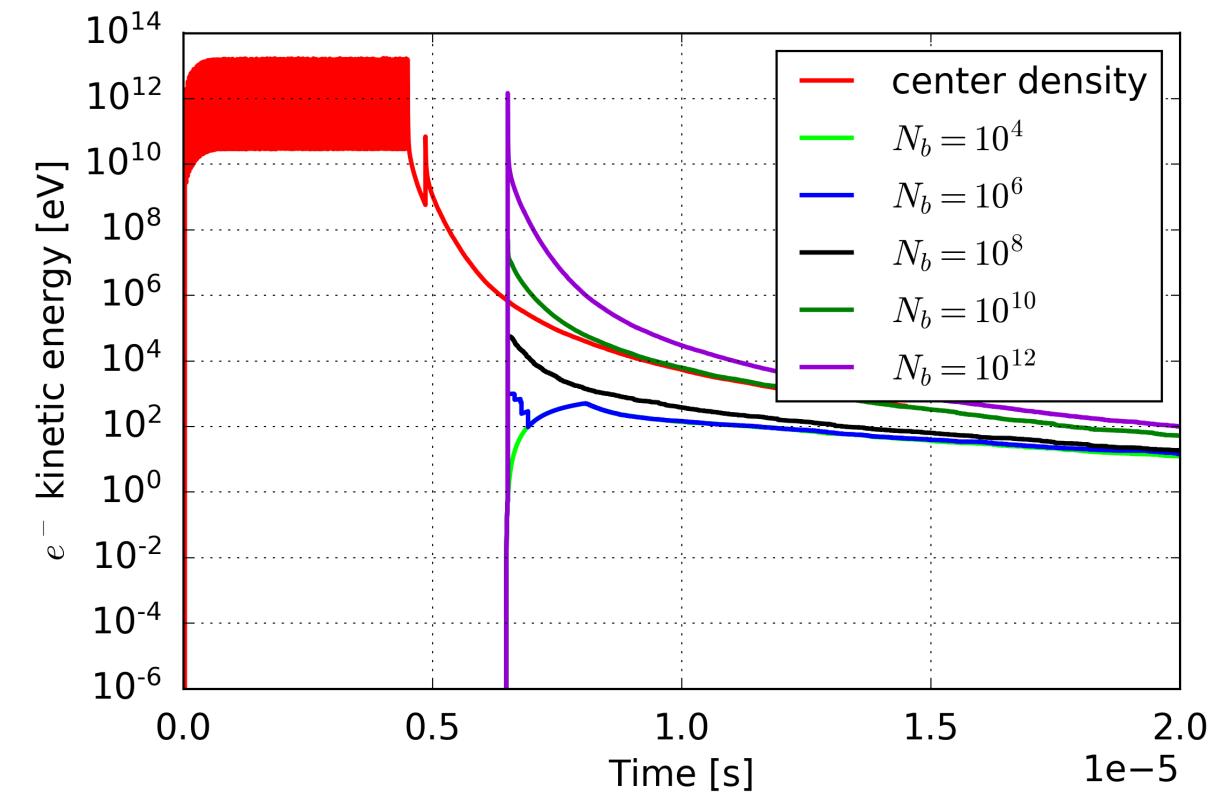
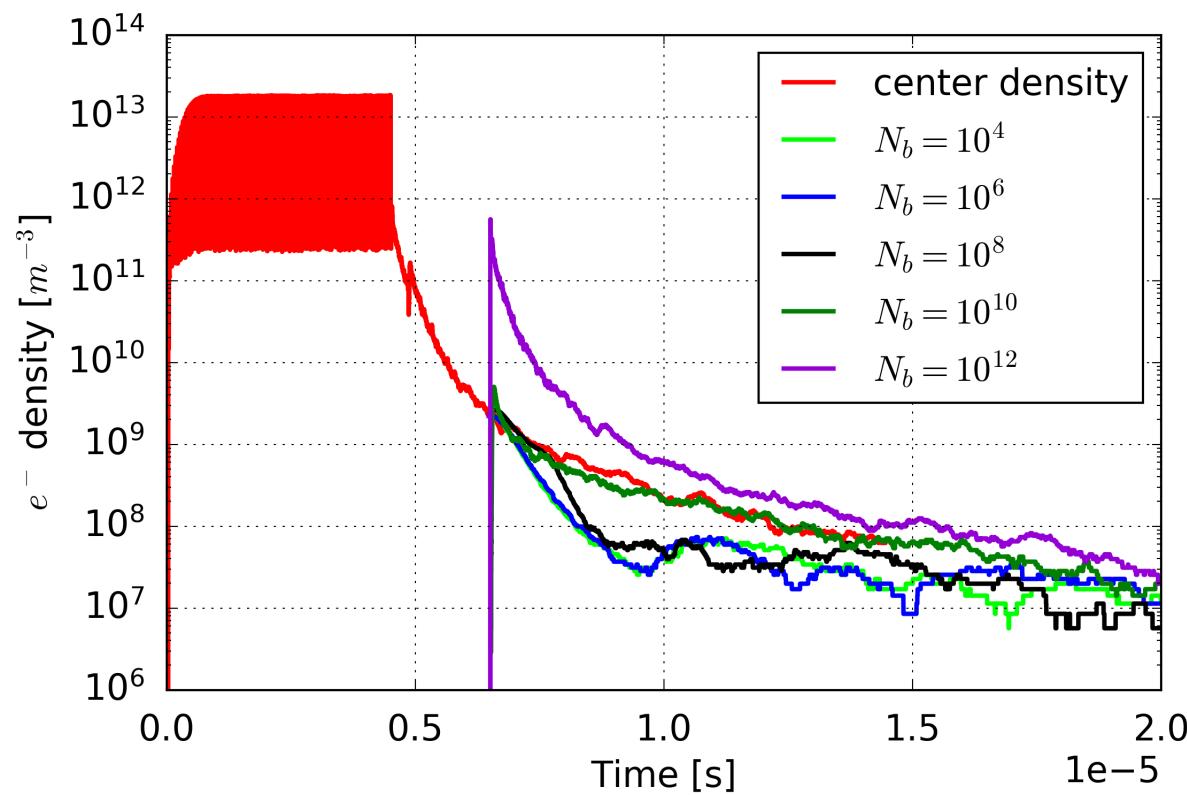
bunch spacing: 30 ns, Furman-Pivi Model, Drift Region



Mitigation tests via single trailing bunch

$$\text{SEY} = 1.4, n'_{(\gamma)} = 1\text{e-}3 \text{ m}^{-1},$$

bunch spacing: 30 ns, Furman-Pivi Model, Drift Region

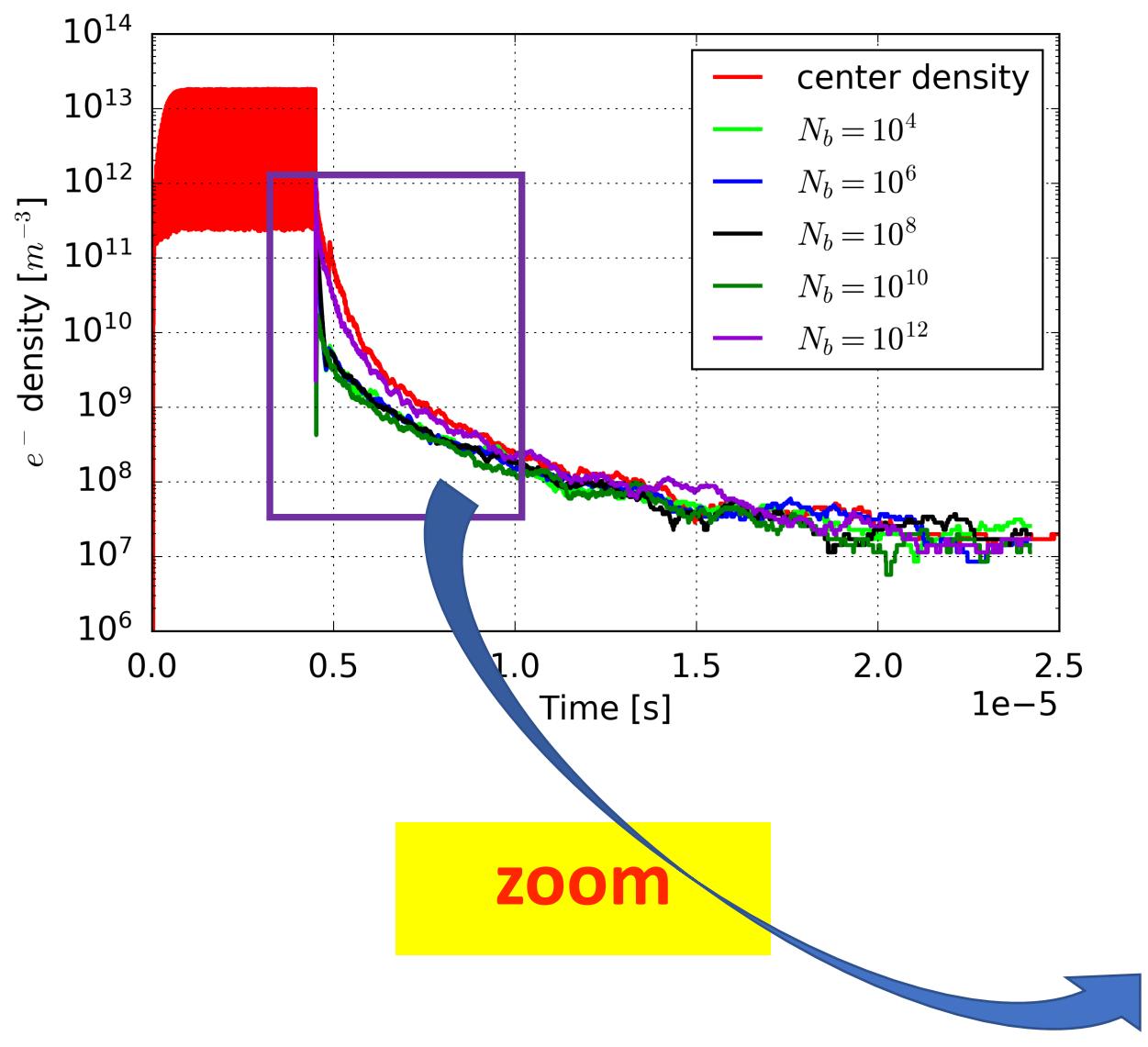


Clearing the residual electrons via low-charge trailing bunch

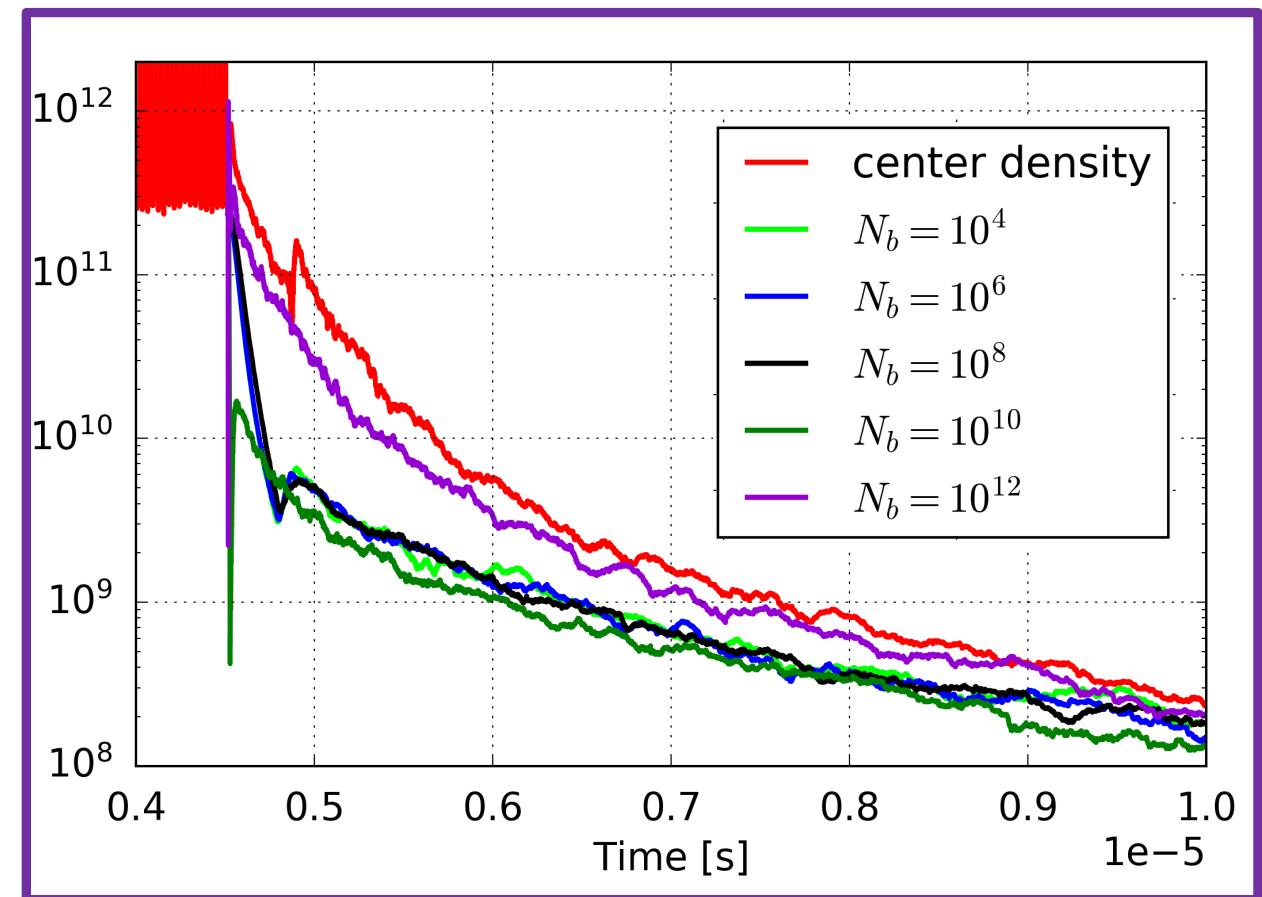


private communication with S. Veitzer (Tech-X), July 2021

Mitigation tests via single trailing bunch



$\text{SEY} = 1.4$, $n'_{(\gamma)} = 1\text{e}-3 \text{ m}^{-1}$,
bunch spacing: 30 ns,
Furman-Pivi Model, Drift Region



Conclusions and Future Plans

- 4IPs parameters & (30ns, 32ns) bunch spacing relax Ecloud build up
- $\simeq [6\text{e}8 - 1.75\text{e}13] \text{ m}^{-3}$ center electron density values for 4IPs parameter scope
- Simulations are performed in the realistic photon flux regimes
- $n'_{(\gamma)} < 1\text{e}-3 \text{ m}^{-1}$ is necessary to keep average minimums lower than the estimated threshold for both SEY models, bunch spacings, dipole & drift regions
- In Drift Region a particular case for both bunch spacings : $(n'_{(\gamma)} = 1\text{e}-4 \text{ m}^{-1}, \text{SEY} = 1.4, \text{FP})$ indicates set of parameters for a value larger than threshold
- Clearing the residual electrons
- Verification of Wakefield calculations, Impedance calculations
- Simulations with the measured SEY data

THANK YOU FOR ATTENTION!



fatihyaman@iyte.edu.tr